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Report No.: SZEM181000893102  
Page: 1 of 33

## TEST REPORT

**Application No.:** SZEM1810008931CR  
**Applicant:** D&M Holdings Inc.  
**Address of Applicant:** 2-1 Nissin-cho, Kawasaki-ku Kawasaki-shi, Kanagawa, 210-8569 Japan  
**Manufacturer:** D&M Holdings Inc.  
**Address of Manufacturer:** 2-1 Nissin-cho, Kawasaki-ku Kawasaki-shi, Kanagawa, 210-8569 Japan  
**Factory:** Dongguan Tai Sing Audio Technology Limited  
**Address of Factory:** Tai Sing Industrial Road, Bai Zhou Bian Village, Dong Cheng, Dongguan City, Guangdong Province 523113, P.R. China

**Equipment Under Test (EUT):**

**EUT Name:** Bluetooth Headphones  
**Model No.:** AH-C820W  
**Trade Mark:** DENON  
**Standard(s) :** MIC Item 19 of Article 2 Paragraph 1  
**Date of Receipt:** 2018-10-12  
**Date of Test:** 2018-10-19  
**Date of Issue:** 2018-11-05

<b>Test Result:</b>	<b>Pass*</b>
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\* In the configuration tested, the EUT complied with the standards specified above.



Keny Xu  
EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2018-11-05		Original

Authorized for issue by:			
		Vincent Chen	
		Vincent Chen /Project Engineer	
		Eric Fu	
		Eric Fu /Reviewer	

## 2 Test Summary

Radio Spectrum Technical Requirement				
Item	Standard	Method	Requirement	Result
Antenna Requirement	MIC Item 19 of Article 2 Paragraph 1	N/A	MIC Item 19 of Article 2 Paragraph 1	Pass
Interference prevention capability	MIC Item 19 of Article 2 Paragraph 1	MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
RF accessibility	MIC Item 19 of Article 2 Paragraph 1	N/A	MIC Item 19 of Article 2 Paragraph 1	Pass

Radio Spectrum Matter Part				
Item	Standard	Method	Requirement	Result
Frequency Error	MIC Item 19 of Article 2 Paragraph 1	MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
Occupied Bandwidth(99%)	MIC Item 19 of Article 2 Paragraph 1	MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
Antenna Power	MIC Item 19 of Article 2 Paragraph 1	MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
Spurious emission Intensity	MIC Item 19 of Article 2 Paragraph 1	MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
Limit of secondary radiated emissions	MIC Item 19 of Article 2 Paragraph 1	MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass

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## 4 General Information

### 4.1 Details of E.U.T.

Power supply:	Li-Ion Polymer Battery DC 3.7V (Charge by DC 5V USB port)
Cable:	USB Cable unshielded 131.5cm
Internal source:	26MHz
Antenna Gain	-8.5dBi
Antenna Type	PCB Antenna
Channel Spacing	2MHz
Modulation Type	GFSK
Number of Channels	40
Operation Frequency	2402MHz to 2480MHz

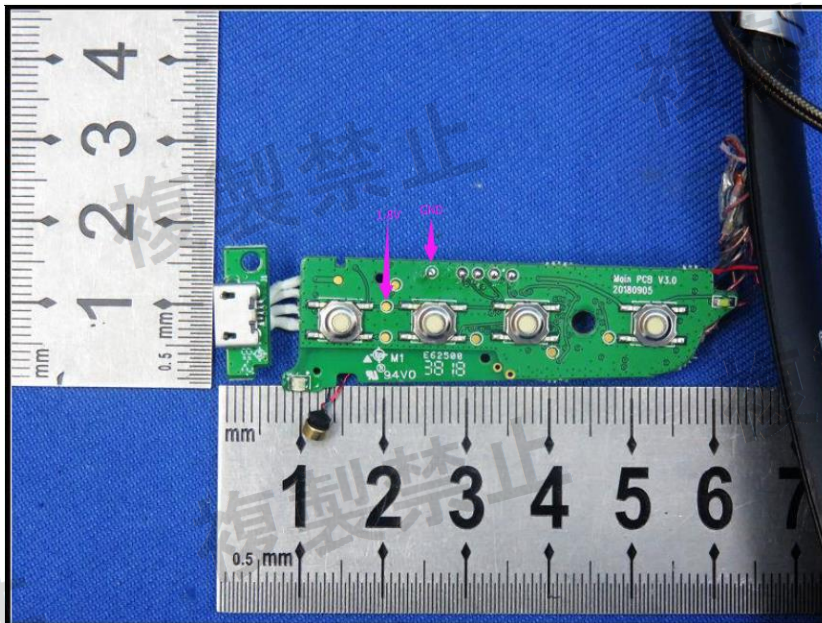
### 4.2 Test Conditions

**Power Supply** Li-Ion Polymer Battery DC 3.7V (Charge by DC 5V USB port)

The RF unit is supplied DC1.8V. The fluctuation of input voltage to the circuit of RF unit of test equipment is under  $\pm 1\%$ , when input voltage from DC3.7V to the test equipment is fluctuated by  $\pm 10\%$ , So, all measurement has been conducted by only rated voltage.

The measurement result of the voltage fluctuation at RF circuit when DC3.7V  $\pm 10\%$ .

DC Input	DC1V80	Power stability(%)
4.07V	1.80V	0.00
3.70V	1.80V	0.00
3.33V	1.80V	0.00



**Temperature:** 0 -45.0 °C  
**Humidity:** 45-85 % RH  
**Atmospheric Pressure:** 1000 -1010 mbar

**Note:**

VN: Normal Voltage  
 TN: Normal Temperature  
 TL: Low Extreme Test Temperature  
 TH: High Extreme Test Temperature

**Test****Frequencies:**

If the EUT can be set to 3 of more different (carrier) frequencies in 1 allocated band, testing shall be performed using the Lowest, Middle and the Highest frequency (L, M and H). If there are 2 or fewer frequencies, testing shall be performed with the available frequencies.

**Operation Frequency each of channel**

Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
1	2402	11	2422	21	2442	31	2462
2	2404	12	2424	22	2444	32	2464
3	2406	13	2426	23	2446	33	2466
4	2408	14	2428	24	2448	34	2468
5	2410	15	2430	25	2450	35	2470
6	2412	16	2432	26	2452	36	2472
7	2414	17	2434	27	2454	37	2474
8	2416	18	2436	28	2456	38	2476
9	2418	19	2438	29	2458	39	2478
10	2420	20	2440	30	2460	40	2480

**Selected Test Channel**

Channel	Frequency
The lowest channel (CH1)	2402MHz
The middle channel (CH21)	2442MHz
The highest channel (CH40)	2480MHz

#### 4.3 Description of Support Units

Description	Manufacturer	Model No.	Serial No.
Adapter	Apple	A1357 W010A051	REF. No.SEA0500
iPhone 6	Apple	MG472ZP/A	C34NHTMFG5MN

#### 4.4 Measurement Uncertainty

No.	Item	Measurement Uncertainty
1	Radio Frequency	$\pm 7.25 \times 10^{-8}$
2	Duty cycle	$\pm 0.37\%$
3	Occupied Bandwidth	$\pm 3\%$
4	RF conducted power	$\pm 0.75\text{dB}$
5	RF power density	$\pm 2.84\text{dB}$
6	Conducted Spurious emissions	$\pm 0.75\text{dB}$
7	RF Radiated power	$\pm 4.5\text{dB}$ (below 1GHz)
		$\pm 4.8\text{dB}$ (above 1GHz)
8	Radiated Spurious emission test	$\pm 4.5\text{dB}$ (Below 1GHz)
		$\pm 4.8\text{dB}$ (Above 1GHz)
9	Temperature test	$\pm 1^{\circ}\text{C}$
10	Humidity test	$\pm 3\%$
11	Supply voltages	$\pm 1.5\%$
12	Time	$\pm 3\%$

#### 4.5 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China.  
518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

#### 4.6 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

- **VCCI**

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

- **FCC –Designation Number: CN1178**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

- **Innovation, Science and Economic Development Canada**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0006.

IC#: 4620C.

#### 4.7 Deviation from Standards

None

#### 4.8 Abnormalities from Standard Conditions

None

## 5 Equipment List

MIC Test Equipment List					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
DC Power Supply	ZhaoXin	RXN-305D	SEM011-02	2018-09-25	2019-09-24
Spectrum Analyzer	Rohde & Schwarz	FSP	SEM004-06	2018-09-27	2019-09-26
Measurement Software	JS Tonscend	JS1120-2 BT/WIFI V2.	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM031-02	2018-07-12	2019-07-11
Attenuator	Weinschel Associates	WA41	SEM021-09	N/A	N/A
Signal Generator	KEYSIGHT	N5173B	SEM006-05	2018-09-27	2019-09-26
Power Meter	Rohde & Schwarz	NRVS	SEM014-02	2018-09-25	2019-09-24

Remark:

- (a) Calibration conducted by the National Institute of Information and Communications Technology (NICT) in Japan (hereinafter referred to as "NICT") or a designated calibration agency under Article 102-18 paragraph (1) in JRL.
- (b) Correction conducted pursuant to the provisions of Article 135 or Article 144 of the Measurement Act (Act No. 51 of 1992) .
- (c) Calibration conducted in countries except Japan, which shall be equivalent to the calibration conducted by the NICT or a designated calibration agency under Article 102-18 paragraph (1).
- (d) Calibration, etc. conducted by using measuring instruments and other equipment listed in the right column of appended table No. 3, which shall have been given any type of calibration, etc. listed above from (a) to (c).

From JRL Article 24-2, paragraph 4, Item 2

**Notice: Calibration duration for above equipments is 1 year.**

## 6 Radio Spectrum Technical Requirement

### 6.1 Antenna Requirement

#### 6.1.1 Test Requirement:

MIC Item 19 of Article 2 Paragraph 1

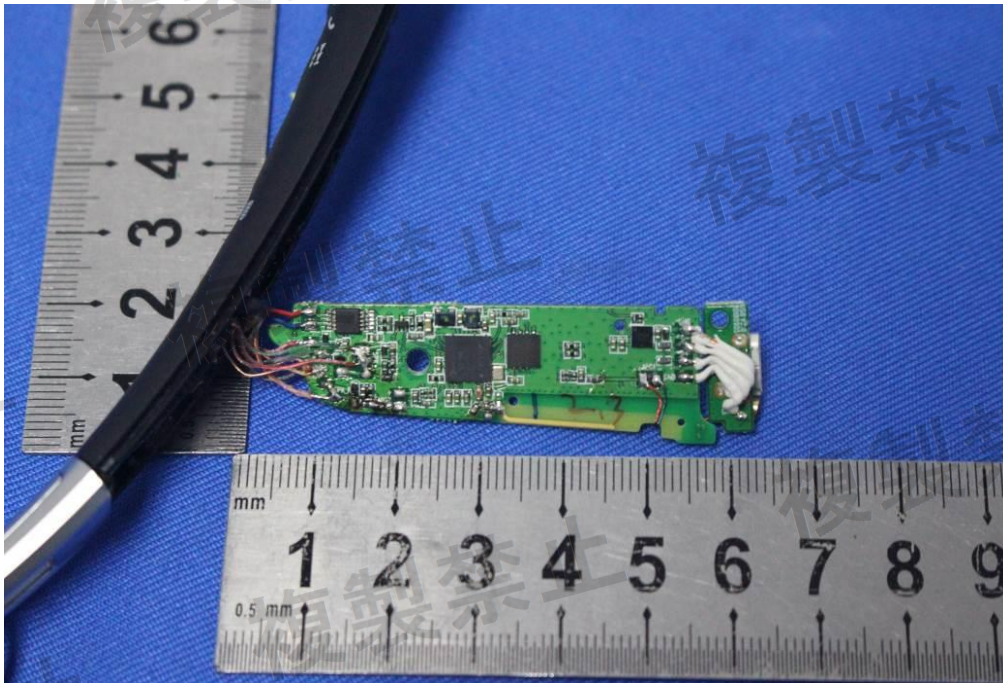
#### 6.1.2 Conclusion

Standard requirement:

Applicable for equipment with an antenna terminal, including testing terminals. If an antenna connector is available, all relevant tests will be carried out conducted. If not, tests will be carried out in an anechoic room or with a suitable test-fixture.

EUT Details:

The antenna is integrated on the main PCB and no consideration of replacement. The best case gain of the antenna is -8.5dBi.



Result:

An antenna connector is available, all relevant tests will be carried out conducted.

## 6.2 Interference prevention capability

### 6.2.1 Test Requirement:

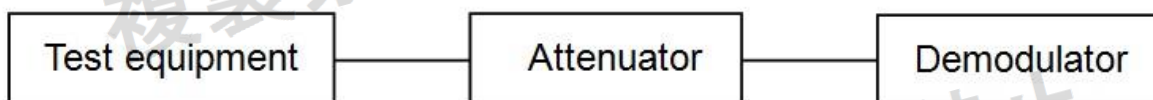
MIC Item 19 of Article 2 Paragraph 1

Limit:

Article 2, Item (19) Notice 88 Appendix 43, 44, 45

The EUT shall be constructed in such a way that sensitive RF parts, (like modulation and oscillator parts) cannot be reached easily by the user. These parts shall be covered by soldered metal caps or glue or by other mechanical covers. If the covers are fixed with screws, these shall be not the common type(s) like a Phillips, but special versions like Torx, so that the user cannot open the device with common tools.

### 6.2.2 Test Setup Diagram



### 6.2.3 Conclusion

Standard Requirement:

- 1) Measurement system diagram as shown above and test equipment keep transmitting identification code.
- 2) Condition of measuring instrument
  - (1) Demodulator must be able to demodulate the transmitting signal emitted by test equipment and to indicate the identification code.
- 3) Condition of test equipment The mode of normal use.
- 4) Measuring operation procedure
  - (1) When test equipment has the function to transmit identification code automatically:
    - A) Transmit the predetermined identification code from test equipment.
    - B) Confirm the transmitted identification code by demodulator.

00:01:5B:00:A5:A2

EUT Details:

The unit does meet the requirements (Good).

### 6.3 RF accessibility

#### 6.3.1 Test Requirement:

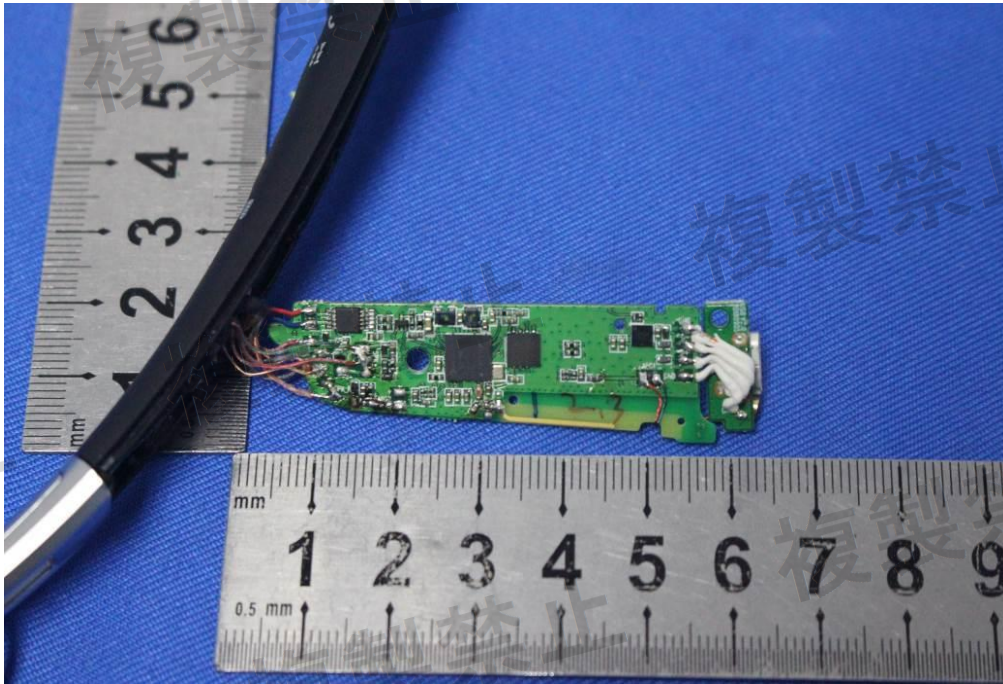
MIC Item 19 of Article 2 Paragraph 1

#### 6.3.2 Conclusion

Standard Requirement:

The EUT shall be constructed in such a way that sensitive RF parts, (like modulation and oscillator parts) cannot be reached easily by the user. These parts shall be covered by soldered metal caps or glue or by other mechanical covers. If the covers are fixed with screws, these shall be not the common type(s) like a Phillips, but special versions like Torx, so that the user cannot open the device with common tools.

EUT Details:



RF and Modulation parts are mounted on PCB with surface mount technology, and there is no any adjustable parts on PCB or adjustable parts are not exposed.

## 7 Radio Spectrum Matter Test Results

### 7.1 Frequency Error

Test Requirement MIC Item 19 of Article 2 Paragraph 1  
Test Method: MIC Notice No.88 Appendix No.43  
Limit: Tolerance of frequency:  $\pm 50\text{E-6}$

#### 7.1.1 E.U.T. Operation

Operating Environment:

Temperature: 20.8 °C Humidity: 51.1 % RH Atmospheric Pressure: 1010 mbar

Test mode e:TX mode\_Keep the EUT in continuously transmitting mode with GFSK modulation

#### 7.1.2 Measurement Procedure and Data

##### 1. Test Conditions:

Spectrum Analyzer is used for measurement.

##### 2. EUT conditions:

Modulation/Spread/Hopping OFF, CW Tx

##### 3. Spectrum Analyzer conditions:

Frequency: Test Frequency

Span 1MHz

RBW 10 kHz (Modulation OFF),

VBW 10 kHz (Modulation OFF),

Sweep Time Auto

Detector mode Positive peak

Indication mode Max hold

##### Alternative method:

Frequency: Test Frequency

Span 2 times channel bandwidth

RBW 100 kHz (Modulation ON),

VBW 100 kHz (Modulation ON),

Sweep Time Auto

Detector mode Positive peak

Indication mode Max hold

The detailed test data see: Appendix MIC19-2

## 7.2 Occupied Bandwidth(99%)

Test Requirement	MIC Item 19 of Article 2 Paragraph 1
Test Method:	MIC Notice No.88 Appendix No.43
Limit:	FH: 83.5MHz or less FH + DS: 83.5MHz or less FH + OFDM: 83.5MHz or less OFDM: 38MHz or less Others: 26MHz or less

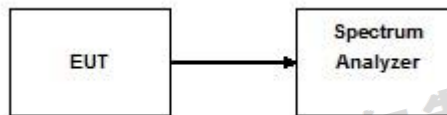
### 7.2.1 E.U.T. Operation

Operating Environment:

Temperature: 20.8 °C Humidity: 51.1 % RH Atmospheric Pressure: 1010 mbar

Test mode e:TX mode\_Keep the EUT in continuously transmitting mode with GFSK modulation

### 7.2.2 Test Setup Diagram



### 7.2.3 Measurement Procedure and Data

#### 1. Test Conditions:

Spectrum Analyzer is used for measurement.

#### 2. EUT conditions:

Modulation/Spread/Hopping ON, Modulation Tx

For equipment using diffusion code, set to the test diffusion code and modulate with standard coding test signal.

#### 3. Spectrum Analyzer conditions:

Frequency: Test Frequency

Span 83.5 MHz (FHSS); 40/60 MHz (OFDM; DSSS); 2-5 times OBW (Others)

RBW 1 MHz (FHSS); 300kHz (OFDM; DSSS); 3% OBW (Others)

VBW 1 MHz (FHSS); 300kHz (OFDM; DSSS); 3 times RBW (Others)

Sweep Time Auto

detector mode Positive peak

Indication mode Max hold

OBW 99%

The detailed test data see: Appendix MIC19-2

### 7.3 Antenna Power

Test Requirement

Test Method:

Limit:

MIC Item 19 of Article 2 Paragraph 1

MIC Notice No.88 Appendix No.43

Designated value

- (1) FH, FH+DS, FH+OFDM: 3mW/MHz  
(used in the range of 2427 - 2470.75 MHz)
  - (2) OFDM, DS other than (1) 10mW/MHz
  - (3) Other than (1) & (2) 10mW
  - (4) OFDM OBW 26 - 38MHz: 5mW/MHz
- Tolerance: +20%, -80%

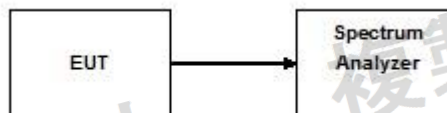
#### 7.3.1 E.U.T. Operation

Operating Environment:

Temperature: 20.8 °C Humidity: 51.1 % RH Atmospheric Pressure: 1010 mbar

Test mode e:TX mode\_Keep the EUT in continuously transmitting mode with GFSK modulation

#### 7.3.2 Test Setup Diagram



#### 7.3.3 Measurement Procedure and Data

1. Test Conditions:

Spectrum Analyzer is used for measurement.

2. EUT conditions:

Modulation/Spread/Hopping ON, Modulation Tx

For equipment using diffusion code, set to the test diffusion code and modulate with standard coding test signal.

3. Spectrum Analyzer conditions:

Frequency: Test Frequency

Span 25 MHz(FHSS); 40/60 MHz (OFDM; DSSS); Enough to capture the emission (Others)

RBW 1 MHz (FHSS; OFDM; DSSS); More than OBW (Others)

VBW 1 MHz (FHSS; OFDM; DSSS); More than RBW (Others)

Sweep Time Auto

detector mode RMS

Indication mode Max hold

The detailed test data see: Appendix MIC19-2

## 7.4 Spurious emission Intensity

Test Requirement MIC Item 19 of Article 2 Paragraph 1

Test Method: MIC Notice No.88 Appendix No.43

Limit:

- (1) Below 2387 MHz : 2.5 $\mu$ W/MHz
- (2) 2387 to 2400 MHz : 25 $\mu$ W/MHz
- (3) 2483.5 through 2496.5 MHz : 25 $\mu$ W/MHz
- (4) Over 2496.5 MHz : 2.5 $\mu$ W/MHz

### 7.4.1 E.U.T. Operation

Operating Environment:

Temperature: 20.8 °C Humidity: 51.1 % RH Atmospheric Pressure: 1010 mbar

Test mode e:TX mode\_Keep the EUT in continuously transmitting mode with GFSK modulation

### 7.4.2 Measurement Procedure and Data

1. Test Conditions:

Spectrum Analyzer is used for measurement.

2. EUT conditions:

Modulation/Spread/Hopping ON, , Modulation Tx

For equipment using diffusion code, set to the test diffusion code and modulate with standard coding test signal.

3. Spectrum Analyzer conditions:

Step 1

All spurious are measured from 30 MHz to 13 GHz by peak mode.

Step 2

IF the value measured by Step1 is 2 dB or less, measure in average mode.

Test setup for Step 1:

Frequency: 30 MHz – 2400 MHz , 2483.5 MHz –13 GHz

RBW 1 MHz

VBW 1 MHz

Sweep Time Auto

detector mode Positive peak

Indication mode Max hold

Test setup for Step 2:

Frequency: Spurious Frequency

RBW 1 MHz

VBW 1 MHz

Sweep Time Auto

detector mode Sample

Indication mode Max hold

The detailed test data see: Appendix MIC19-2

## 7.5 Limit of secondary radiated emissions

Test Requirement	MIC Item 19 of Article 2 Paragraph 1
Test Method:	MIC Notice No.88 Appendix No.43
Limit:	(1) Below 1 GHz : 4 nW or less (2) 1 GHz and over : 20 nW or less

### 7.5.1 E.U.T. Operation

Operating Environment:

Temperature: 20.8 °C Humidity: 51.1 % RH Atmospheric Pressure: 1010 mbar

Test mode e:TX mode\_Keep the EUT in continuously transmitting mode with GFSK modulation

### 7.5.2 Measurement Procedure and Data

#### 1. Test Conditions:

Spectrum Analyzer is used for measurement.

#### 2. EUT conditions:

Modulation/Spread/Hopping ON

For equipment using diffusion code, set to the test diffusion code and modulate with standard coding test signal.

#### 3. Spectrum Analyzer conditions:

##### Step 1

All spurious are measured from 30 MHz to 13 GHz by peak mode.

##### Step 2

IF the value measured by Step1 is 2 dB or less, measure in average mode.

Test setup for Step 1:

Frequency: 30 MHz – 2400 MHz , 2483.5 MHz –13 GHz

RBW 100 kHz (30 – 1GHz) , 1 MHz (over 1GHz)

VBW 100 kHz (30 – 1GHz) , 1 MHz (over 1GHz)

Sweep Time Auto

detector mode Positive peak

Indication mode Max hold

Test setup for Step 2:

Frequency: Spurious Frequency

Span 0 Hz

RBW 100 kHz (30 – 1GHz) , 1 MHz (over 1GHz)

VBW 100 kHz (30 – 1GHz) , 1 MHz (over 1GHz)

Sweep Time Auto

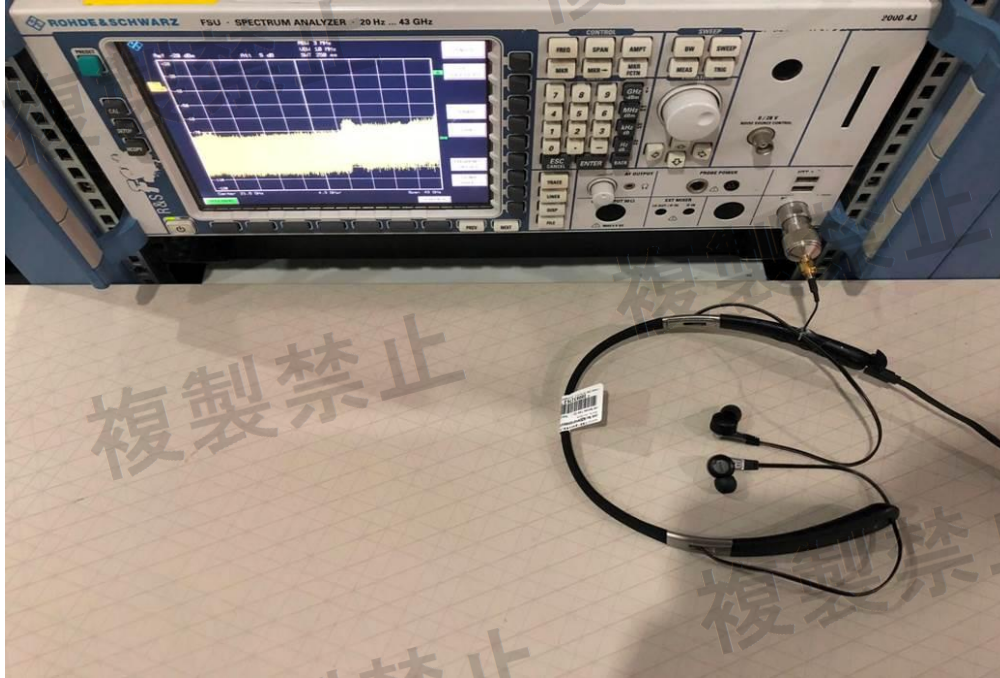
detector mode Sample

Indication mode Max hold

The detailed test data see: Appendix MIC19-2

## 8 Photographs

### 8.1 EUT Test Setup



### 8.2 EUT Constructional Details (EUT Photos)

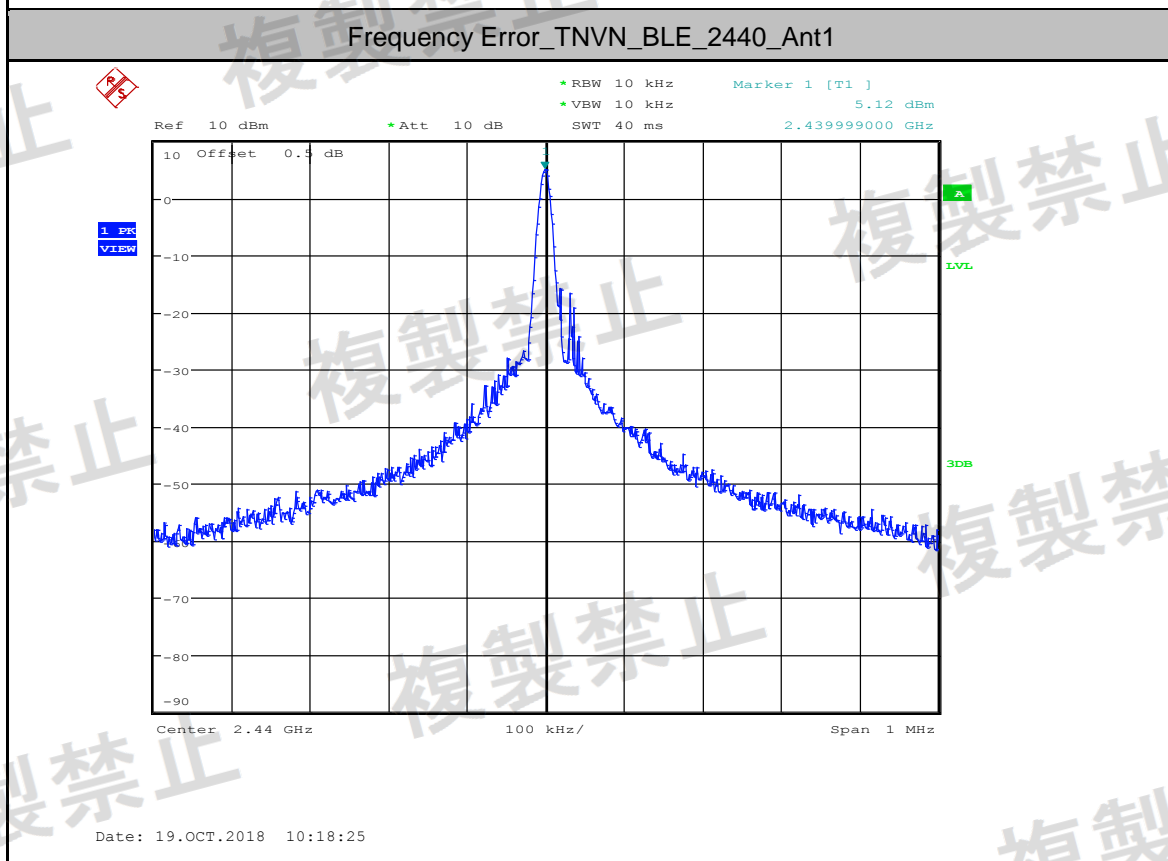
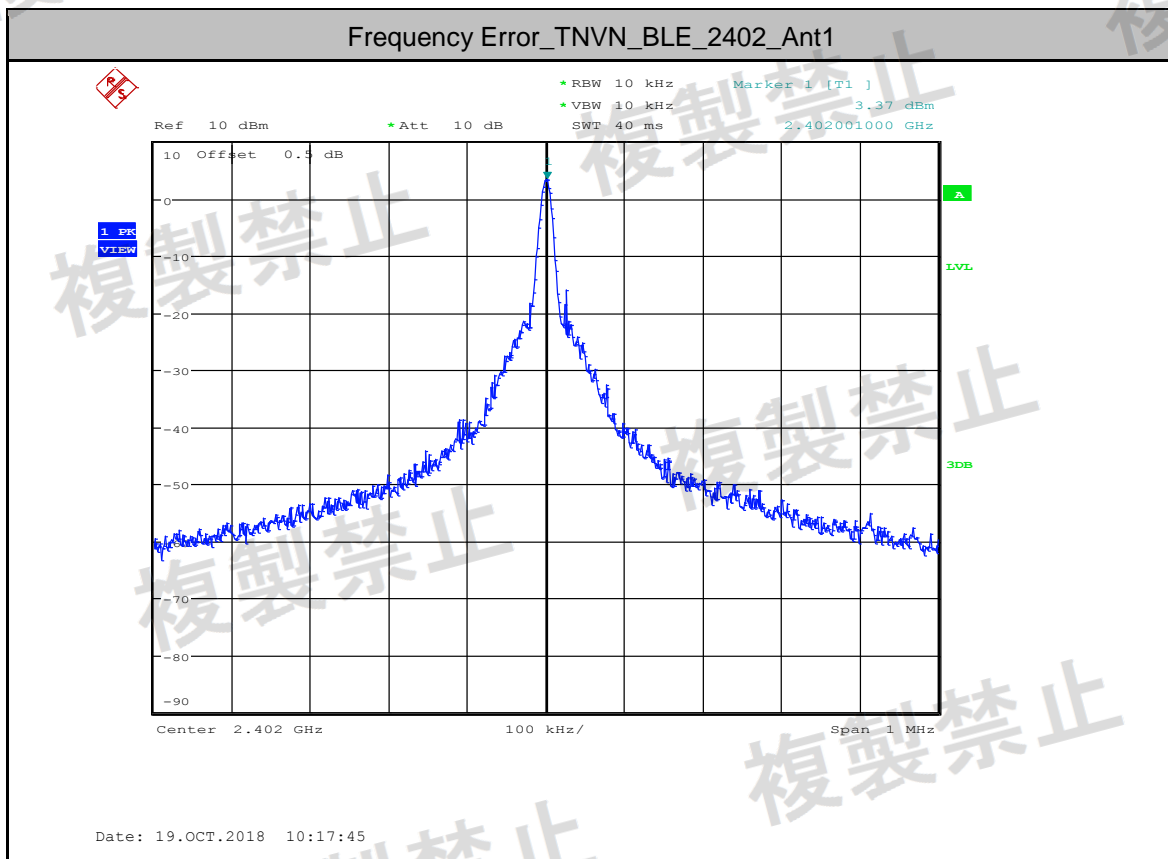
Refer to Appendix A - Photographs of EUT Constructional Details for SZEM1810008931CR.

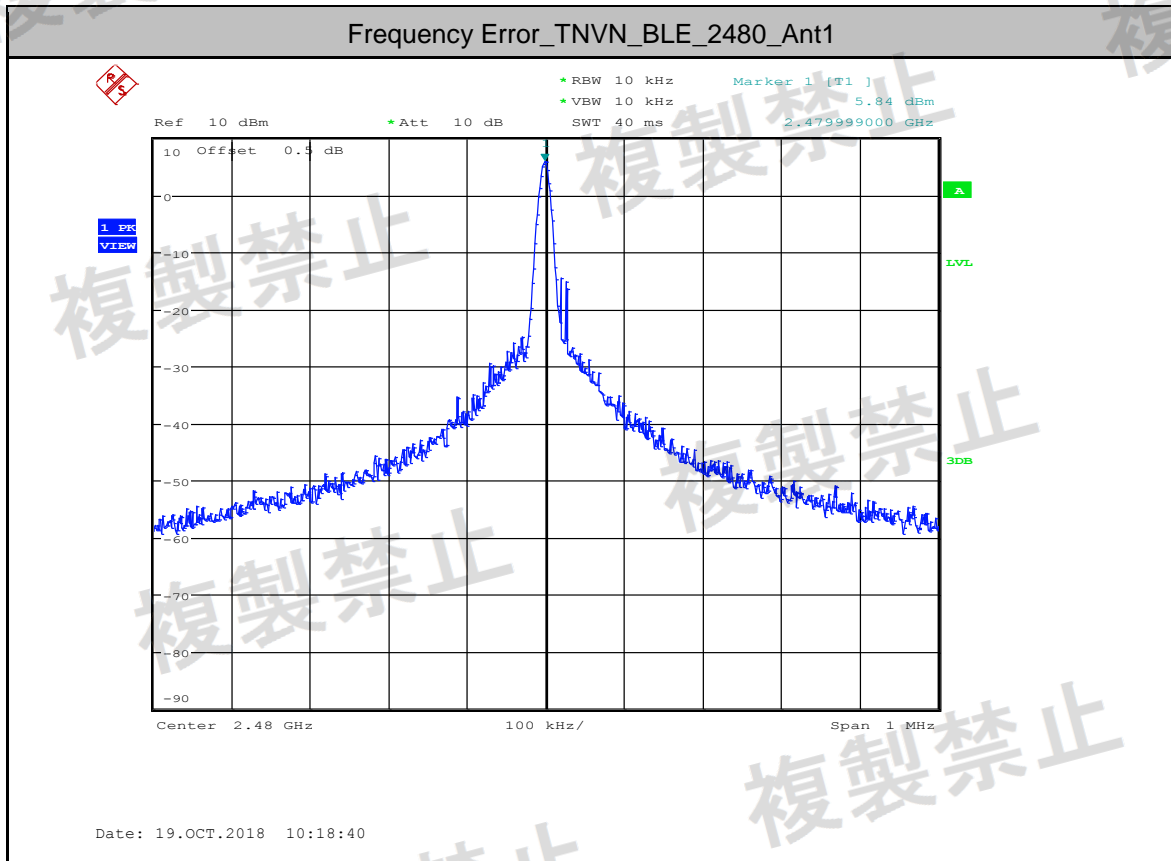
## 9 Appendix

### 9.1 Appendix MIC19-2

#### 1.Frequency Error

Test Condition	Test Mode	Test Channel	Ant	Result [MHz]	Result [PPM]	Limit [PPM]	Verdict
TNVN	BLE	2402	Ant1	2402.001	0.42	$\leq \pm 50$	PASS
TNVN	BLE	2440	Ant1	2439.999	-0.41	$\leq \pm 50$	PASS
TNVN	BLE	2480	Ant1	2479.999	-0.4	$\leq \pm 50$	PASS

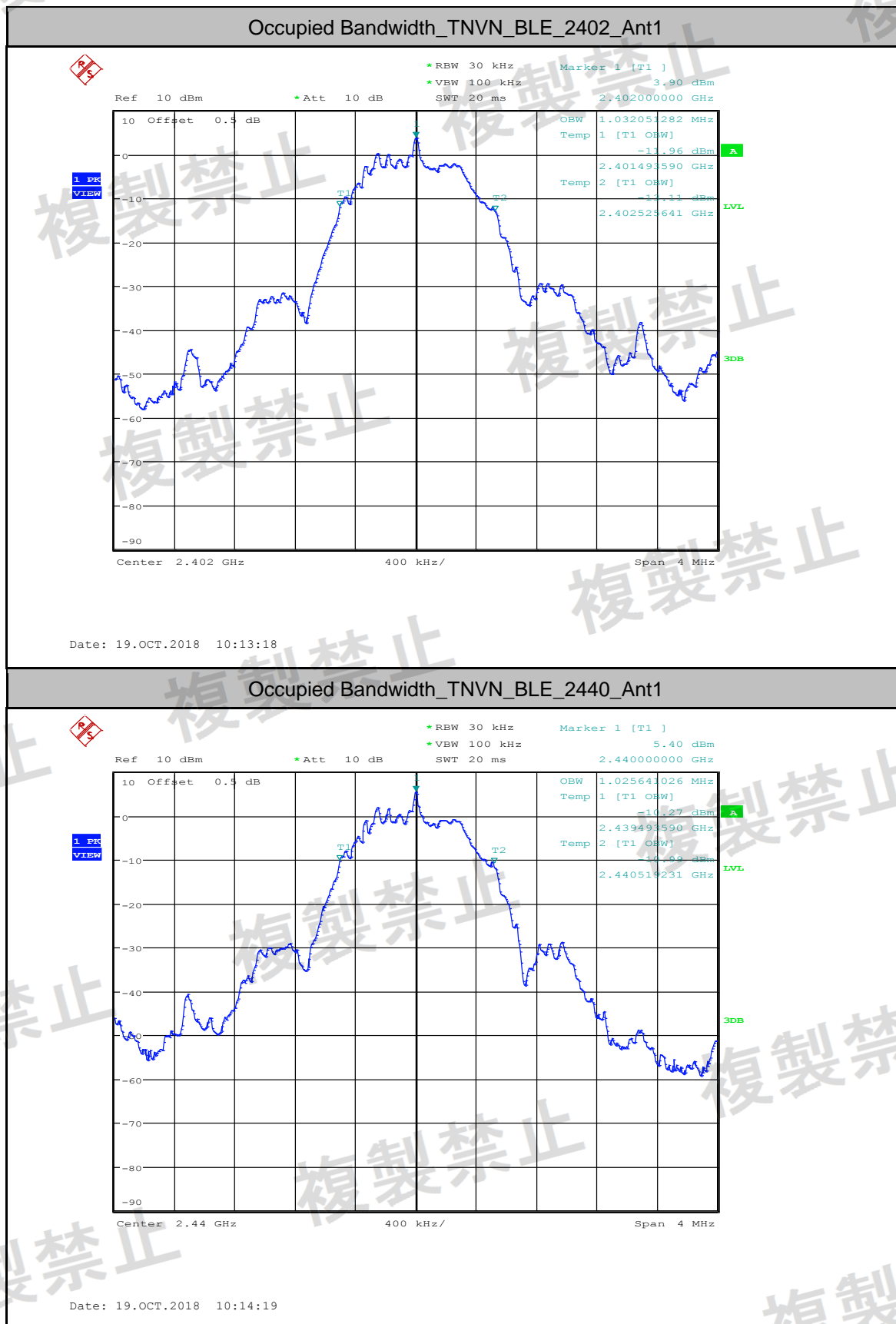


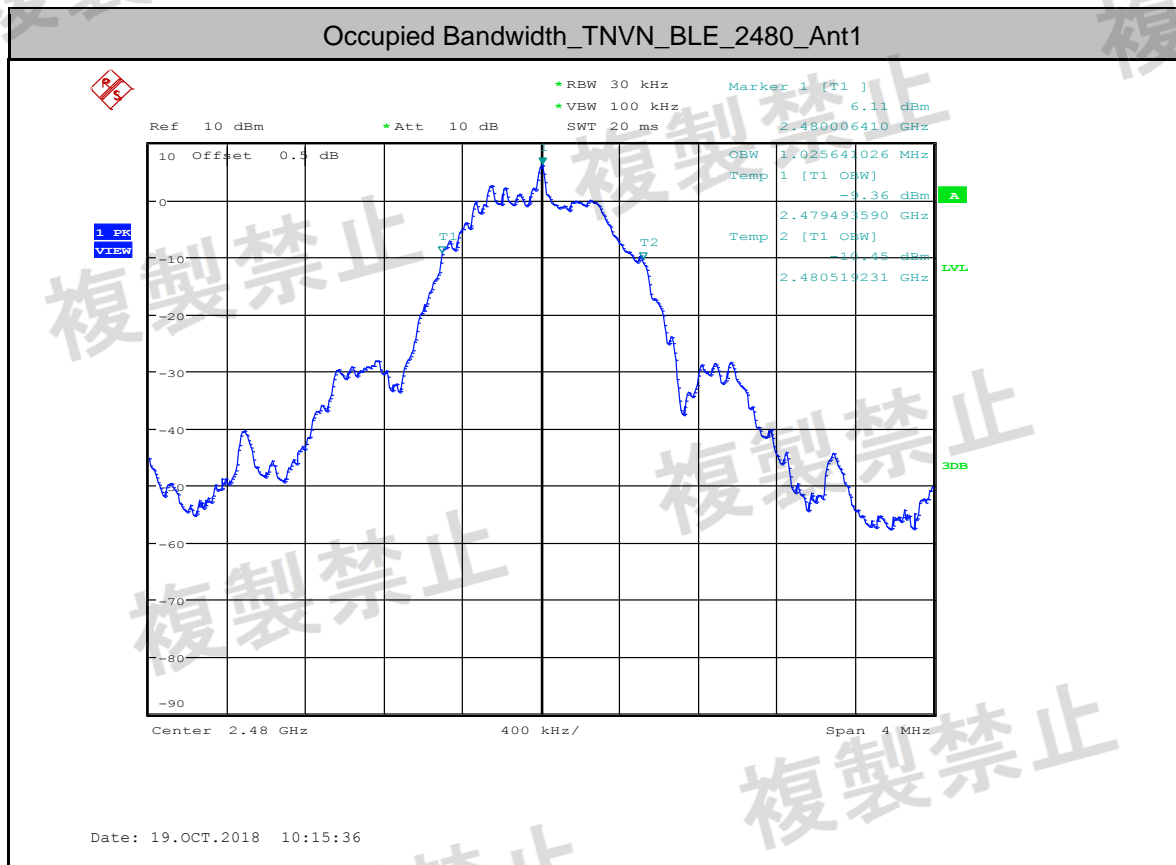




2.Occupied Bandwidth (99%)

Test Condition	Test Mode	Test Channel	Ant	Test Result [MHz]	Limit [MHz]	Verdict
TNVN	BLE	2402	Ant1	1.032	<=26	PASS
TNVN	BLE	2440	Ant1	1.026	<=26	PASS
TNVN	BLE	2480	Ant1	1.026	<=26	PASS

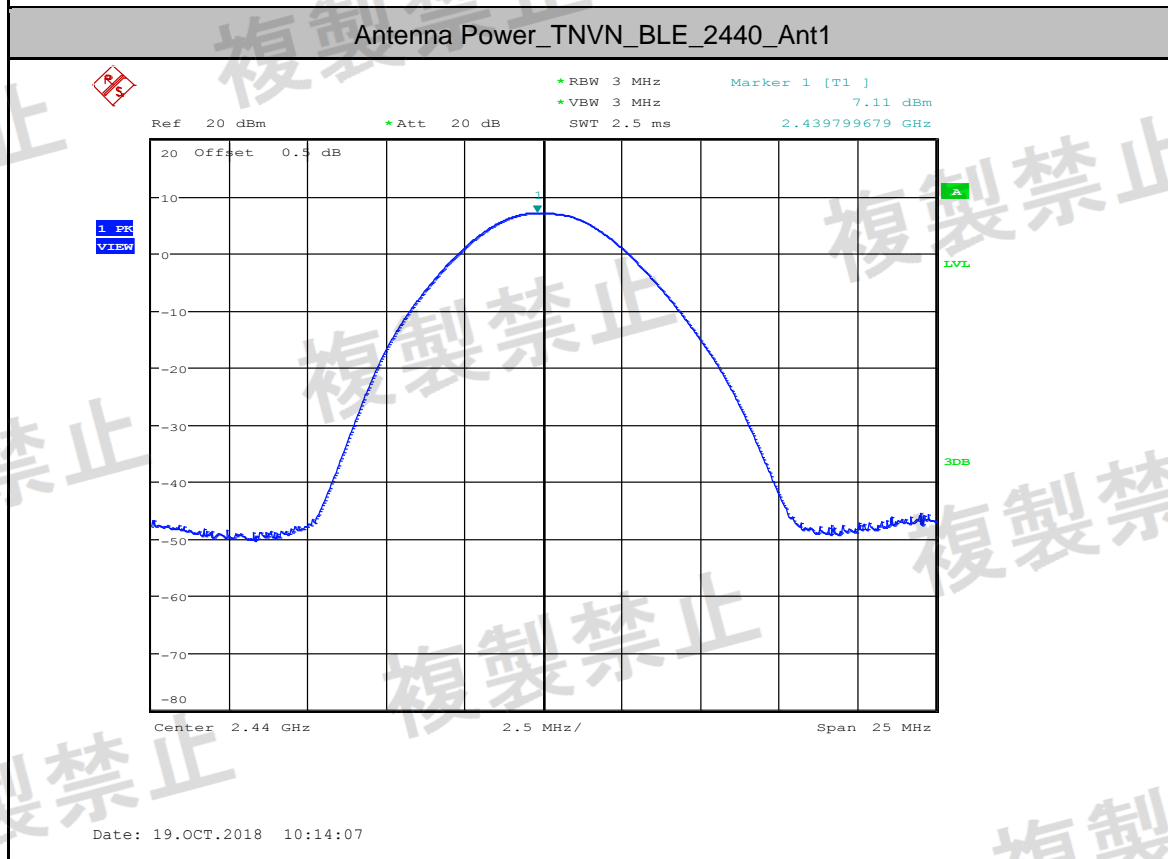
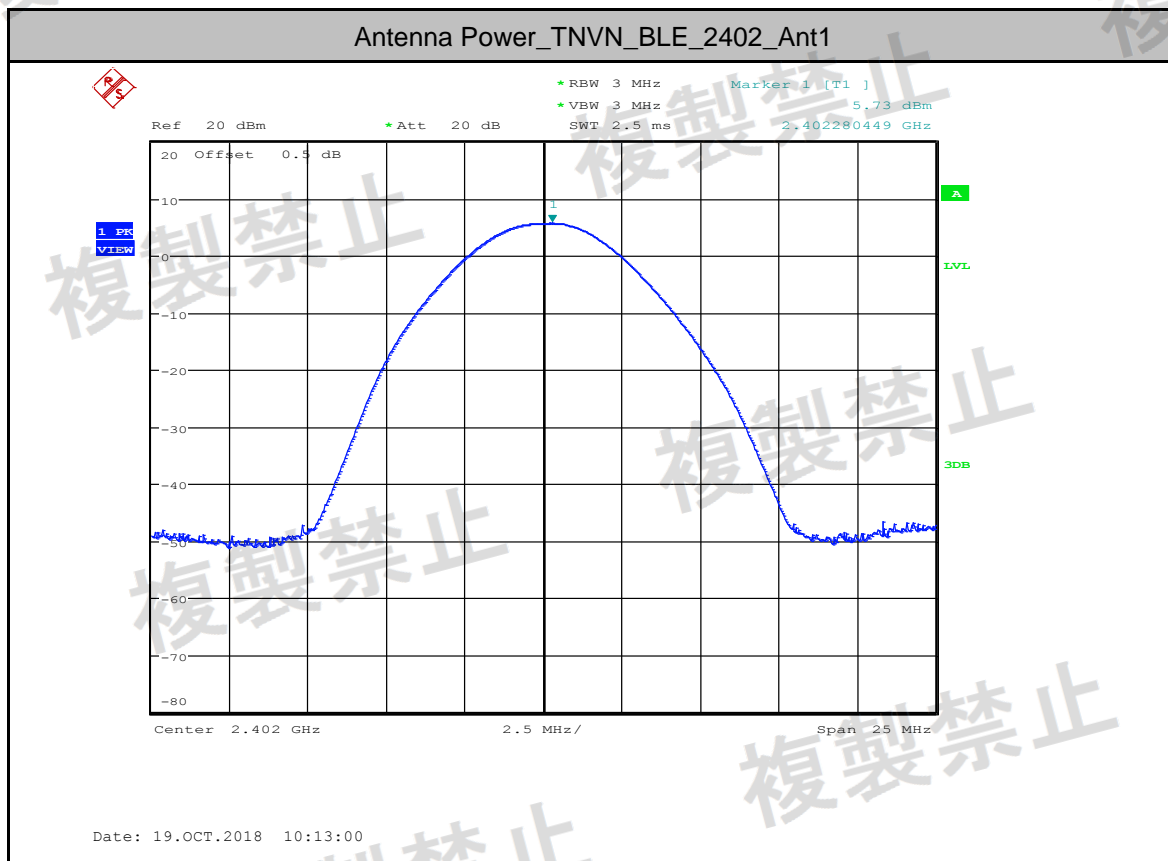


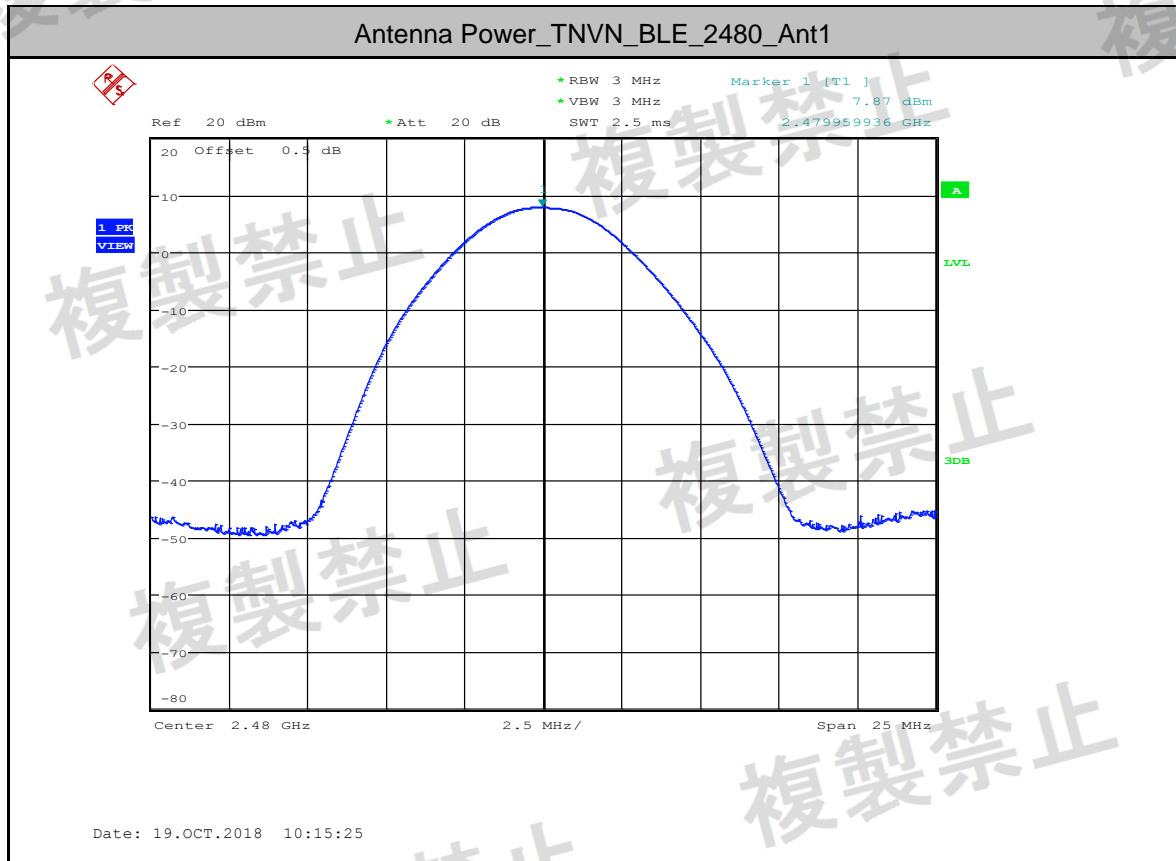




3.Antenna Power

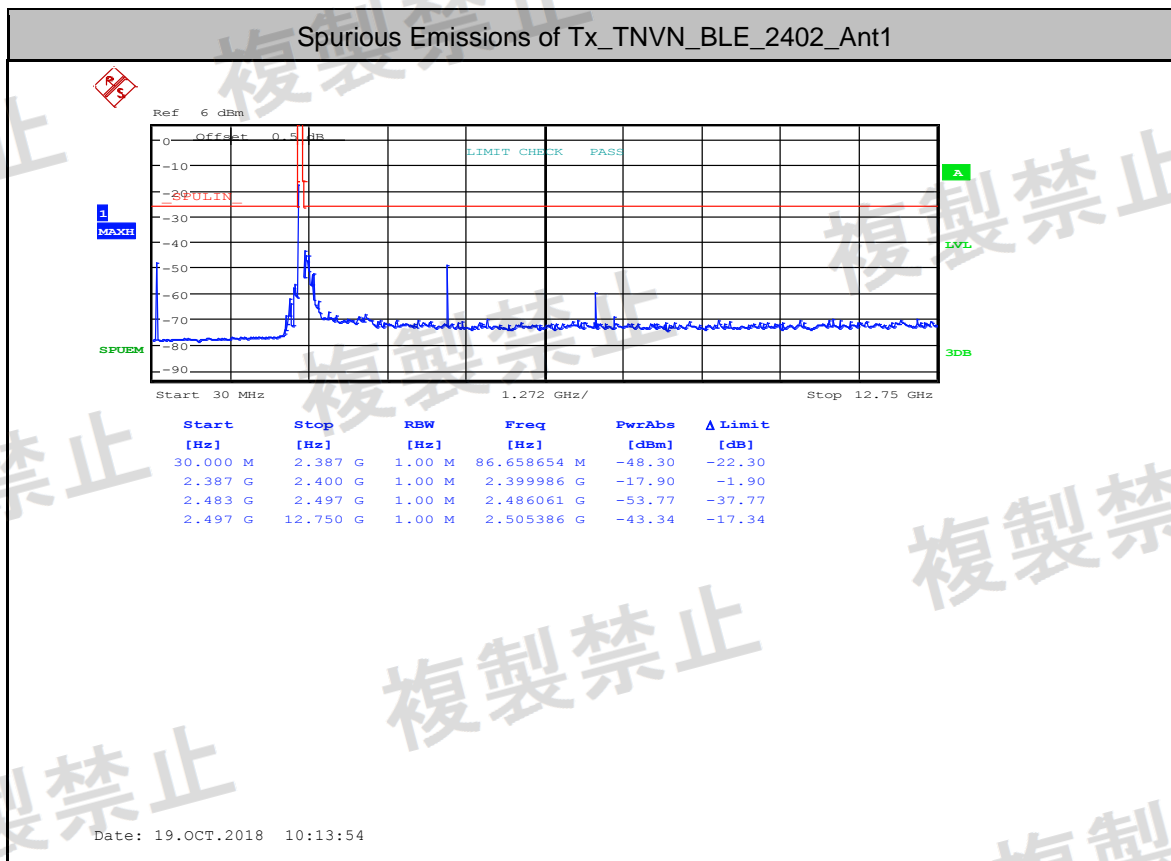
Test Condition	Test Mode	Test Channel	Ant	Power [mW]	Limit [mW]	Normal Power [mW]	Tolerance[%]	Limit [%]	Verdict
TNVN	BLE	2402	Ant1	3.74	10	6	-37.667	-80 to +20	PASS
TNVN	BLE	2440	Ant1	5.14	10	6	-14.333	-80 to +20	PASS
TNVN	BLE	2480	Ant1	6.12	10	6	2.000	-80 to +20	PASS



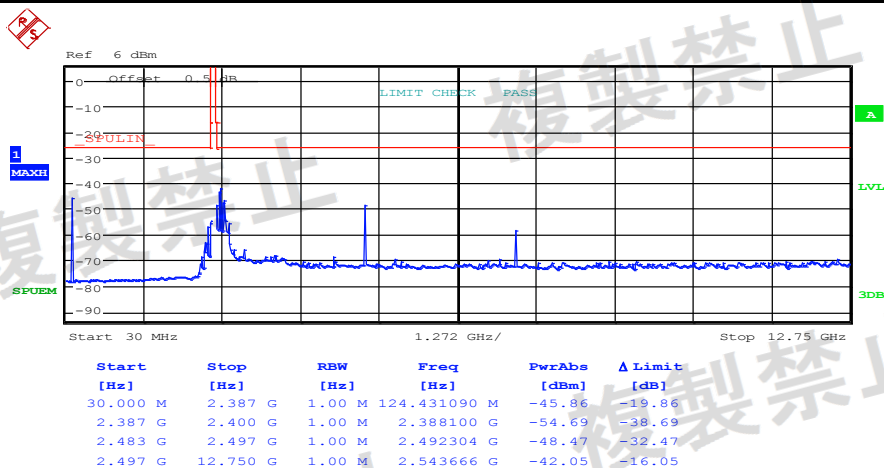


#### 4.Spurious Emissions of Tx

Test Mode	Test Channel	StartFre[MHz]	StopFre[MHz]	Max.Fre[MHz]	Max.Level[μW]	Limit [μW]	Verdict
BLE	2402	30	2387	86.66	0.0148	2.5	PASS
BLE	2402	2387	2400	2399.99	16.2181	25.1	PASS
BLE	2402	2483.5	2496.5	2486.06	0.0042	25.1	PASS
BLE	2402	2496.5	13000	2505.39	0.0463	2.5	PASS
BLE	2440	30	2387	124.43	0.0259	2.5	PASS
BLE	2440	2387	2400	2388.10	0.0034	25.1	PASS
BLE	2440	2483.5	2496.5	2492.30	0.0142	25.1	PASS
BLE	2440	2496.5	13000	2543.67	0.0624	2.5	PASS
BLE	2480	30	2387	165.98	0.0372	2.5	PASS
BLE	2480	2387	2400	2399.93	0.0008	25.1	PASS
BLE	2480	2483.5	2496.5	2483.50	0.4295	25.1	PASS
BLE	2480	2496.5	13000	2583.65	0.0610	2.5	PASS

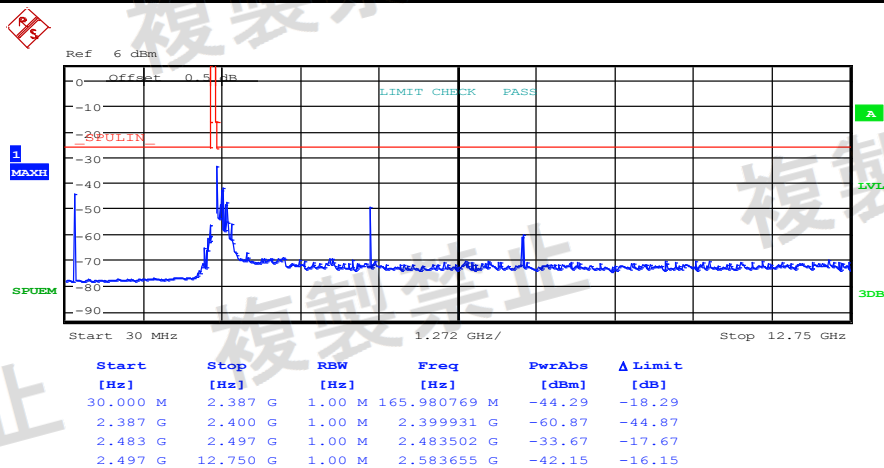


## Spurious Emissions of Tx\_TNVN\_BLE\_2440\_Ant1



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## Spurious Emissions of Tx\_TNVN\_BLE\_2480\_Ant1

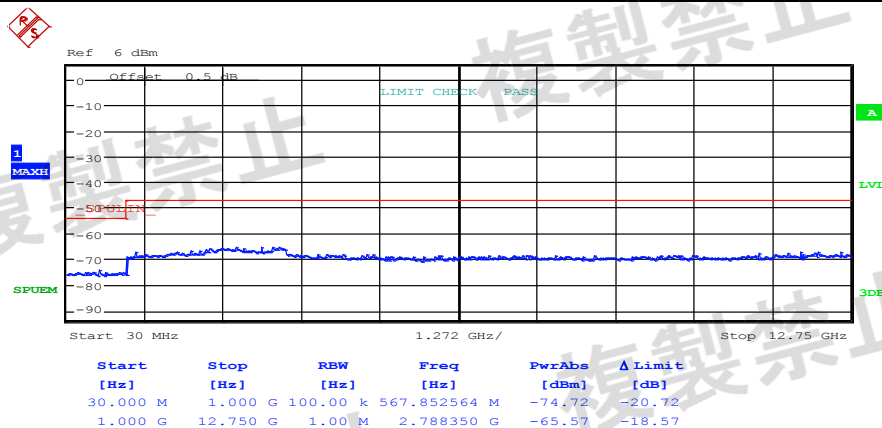


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**5.Spurious Emissions of Rx**

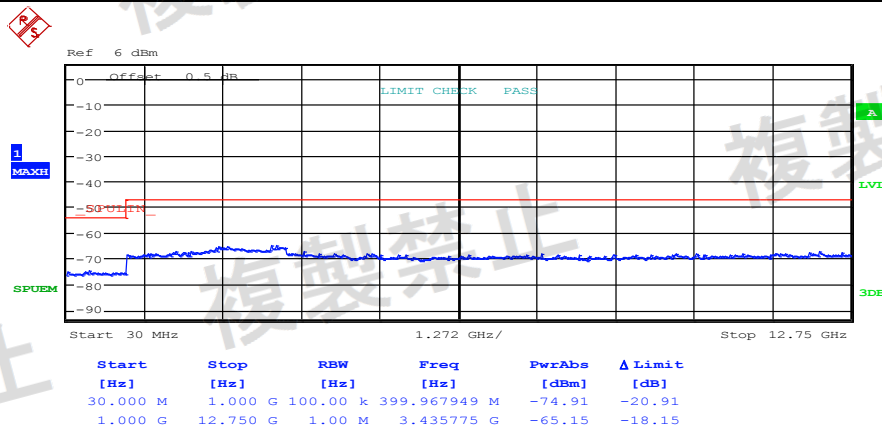
Test Mode	Test Channel	StartFre[MHz]	StopFre[MHz]	Max.Fre[MHz]	Max.Level[nW]	Limit [nW]	Verdict
BLE	2402	1000	13000	2788.35	0.277	20	PASS
BLE	2402	30	1000	567.85	0.034	4	PASS
BLE	2440	1000	13000	3435.77	0.305	20	PASS
BLE	2440	30	1000	399.97	0.032	4	PASS
BLE	2480	1000	13000	3502.75	0.312	20	PASS
BLE	2480	30	1000	403.08	0.030	4	PASS

## Spurious Emissions of Rx\_TNVN\_BLE\_2402\_Ant1

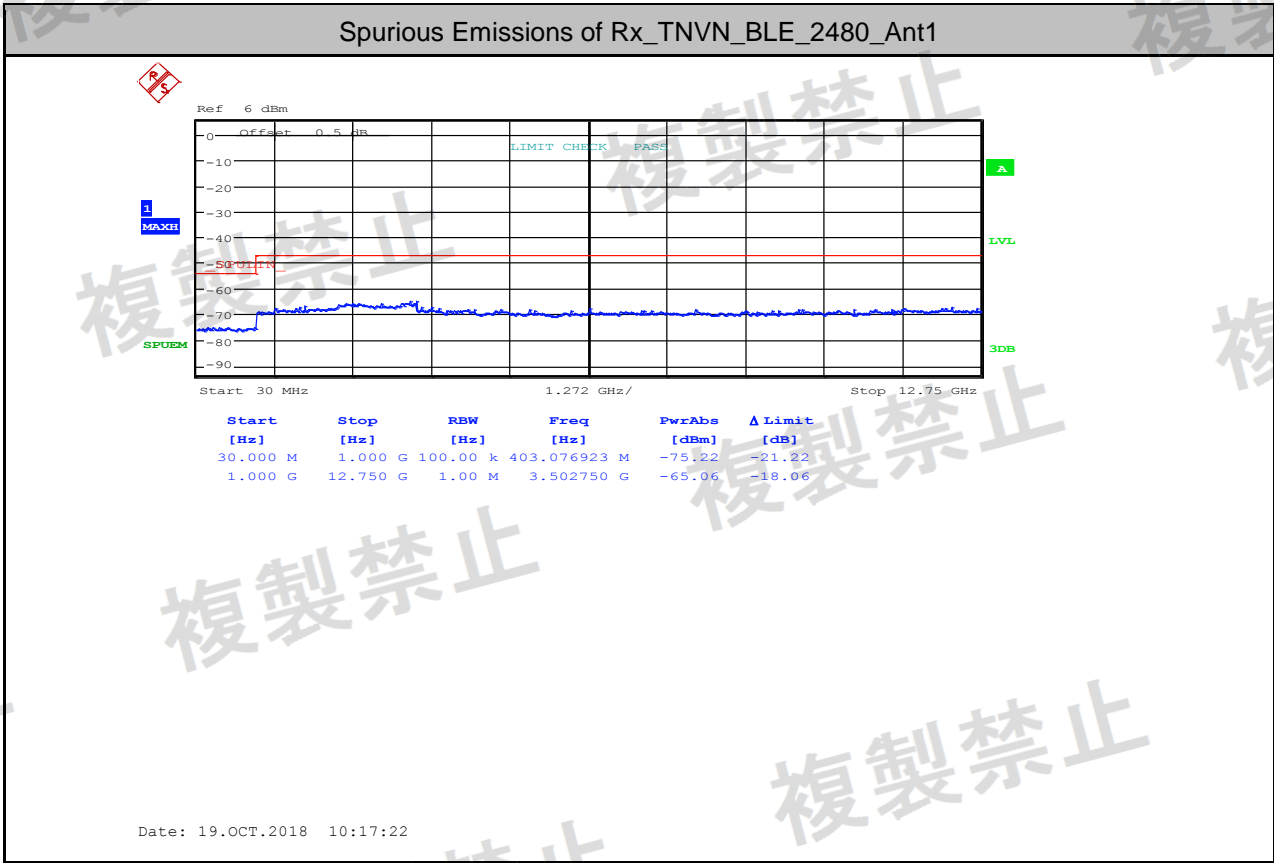


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## Spurious Emissions of Rx\_TNVN\_BLE\_2440\_Ant1



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- End of the Report -